Docket No. 740756-2138

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n re Patent Application of)			
	Takayuki IKEDA et al.)	Examiner: Ahmed N. SEFER		
Serial No. 09/542,473)			
Filed:	April 4, 2000)	Group Art Unit: 2826		
For:	ELECTROOPTICAL DEVICE AND A METHOD)	Confirmation No. 6069		
	OF MANUFACTURING THE SAME)			

Certificate of Mailing

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to: Commissioner for Patents, Washington, DC 20231, on January 29, 2004

Name: Sacob A. Poushter

FOURTH REQUEST FOR ACKNOWLEDGMENT OF INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Washington, D.C. 20231

Sir:

An Information Disclosure Statement with Form PTO-1449 was filed in the above-identified patent application on September 4, 2001. Applicants have received back from the Examiner a copy of the Form PTO-1449 partially initialed to acknowledge the fact that the Examiner has considered the cited disclosed information.

The Examiner is requested to initial and return to the undersigned a copy of the subject Form PTO-1449.

Should there be any questions concerning this communication, please telephone the undersigned at the number set forth below.

Respectfully submitted,

Jeffrey L. Costellia Registration No. 35,483

Nixon Peabody LLP

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Form PTO-1449 (Rev. 8-82) INFORMATION DISCLOSURE STATEMENT FEB 0 2 2004			Atty Docket 0756-2-38		Serial No. 09/542,473					
		Applicants: Takayuki IKEDA								
			Filing Date: April 04, 2000		Group Art Unit: 2826					
U.S. PATENT DOCUMENTS Examiner Document Number Date Name Class Subclass Filing Date (if appropriate)										
Examiner	Document Number	Date	Name	Class	Subclass	Filing Date (if appropriate)				
Initial ⁾	6,013,929	01/11/2000	Ohtani		·					
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)										
Examiner Initial	Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specifications and Drawings for Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit and Specification Serial No. 08/862,895, "Semiconductor Intergrated Circuit Application Serial No. 08/862,895, "Semiconductor Intergrated Circuit No. 08/862, "Semiconductor Intergrated Circuit No. 08/862, "Semicond									
	Specifications and Drawings for Application Schall No. 1997, Inventor: Hisashi OHTANI Fabrication Method Thereof", Filing Date: May 23, 1997, Inventor: Hisashi OHTANI Specifications and Drawings for Application Serial No. 09/468,859, "Thin Film Transistor, Method of Manufacturing the Same, and Semiconductor Device Including the Same" Filing Date: December 21, 1999, Inventor: Hisashi									
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	Specifications and Drawings for Application Serial No. 63/167; 25/167; 25/167; 25/167; 26/167;									
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Date Considered

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this formwith next communication to applicant.

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100/104/2001